

NP28N10SDE

R07DS0507EJ0100

Rev.1.00

MOS FIELD EFFECT TRANSISTOR

Sep 16, 2011

Description

The NP28N10SDE is N-channel MOS Field Effect Transistor designed for high current switching applications.

Features

- Low on-state resistance
 $R_{DS(on)1} = 52 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 14 \text{ A)}$
 $R_{DS(on)2} = 59 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 14 \text{ A)}$
- Low C_{iss} : $C_{iss} = 2200 \text{ pF TYP. (} V_{DS} = 25 \text{ V)}$
- Designed for automotive application and AEC-Q101 qualified

Ordering Information

Part No.	Lead Plating	Packing		Package
NP28N10SDE-E1-AY *1	Pure Sn (Tin)	Tape 2500 p/reel	Taping (E1 type)	TO-252 (MP-3ZK)
NP28N10SDE-E2-AY *1			Taping (E2 type)	

Note: *1. Pb-free (This product does not contain Pb in the external electrode.)

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$)

Item	Symbol	Ratings	Unit
Drain to Source Voltage ($V_{GS} = 0 \text{ V}$)	V_{DSS}	100	V
Gate to Source Voltage ($V_{DS} = 0 \text{ V}$)	V_{GSS}	± 20	V
Drain Current (DC) ($T_C = 25^\circ\text{C}$)	$I_{D(DC)}$	± 28	A
Drain Current (pulse) *1	$I_{D(pulse)}$	± 60	A
Total Power Dissipation ($T_C = 25^\circ\text{C}$)	P_{T1}	100	W
Total Power Dissipation ($T_A = 25^\circ\text{C}$) *2	P_{T2}	1.2	W
Channel Temperature	T_{ch}	175	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +175	$^\circ\text{C}$
Single Avalanche Current *3	I_{AS}	24	A
Single Avalanche Energy *3	E_{AS}	58	mJ

Thermal Resistance

Channel to Case Thermal Resistance $R_{th(ch-C)} = 1.50 \text{ }^\circ\text{C/W}$

Channel to Ambient Thermal Resistance *2 $R_{th(ch-A)} = 125 \text{ }^\circ\text{C/W}$

Notes: *1. $T_C = 25^\circ\text{C}$, $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$

*2. Mounted on glass epoxy substrate of 40 mm \times 40 mm \times 1.6 mm with 4% Copper area (35 μm)

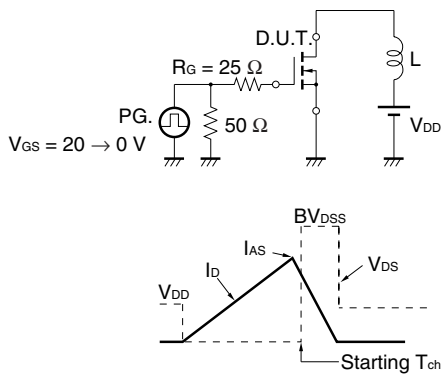
*3. $T_{ch(start)} = 25^\circ\text{C}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, $L = 100 \mu\text{H}$, $V_{GS} = 20 \text{ V} \rightarrow 0 \text{ V}$

Electrical Characteristics (T_A = 25°C)

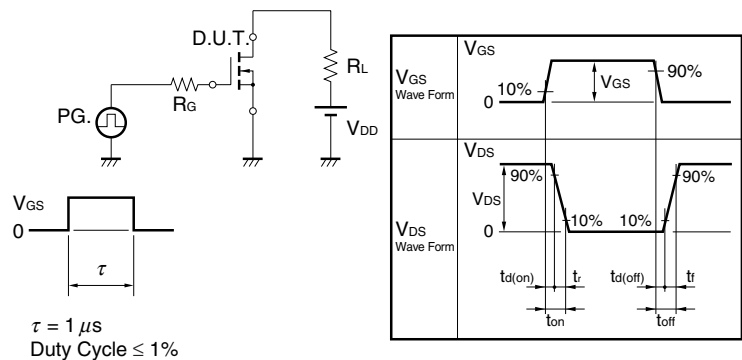
Item	Symbol	MIN.	TYP.	MAX.	Unit	Test Conditions
Zero Gate Voltage Drain Current	I _{DSS}			10	μA	V _{DS} = 100 V, V _{GS} = 0 V
Gate Leakage Current	I _{GSS}			±100	nA	V _{GS} = ±20 V, V _{DS} = 0 V
Gate to Source Threshold Voltage	V _{GS(th)}	1.5	2.0	2.5	V	V _{DS} = V _{GS} , I _D = 250 μA
Forward Transfer Admittance *1	y _{fs}	9	18		S	V _{DS} = 10 V, I _D = 14 A
Drain to Source On-state Resistance *1	R _{DS(on)1}		41	52	mΩ	V _{GS} = 10 V, I _D = 14 A
	R _{DS(on)2}		45	59	mΩ	V _{GS} = 4.5 V, I _D = 14 A
Input Capacitance	C _{iss}		2200	3300	pF	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz
Output Capacitance	C _{oss}		160	240	pF	
Reverse Transfer Capacitance	C _{rss}		90	165	pF	
Turn-on Delay Time	t _{d(on)}		12	39	ns	V _{DD} = 50 V, I _D = 14 A, V _{GS} = 10 V R _G = 0 Ω
Rise Time	t _r		9	23	ns	
Turn-off Delay Time	t _{d(off)}		53	106	ns	
Fall Time	t _f		5	13	ns	
Total Gate Charge	Q _G		49	75	nC	V _{DD} = 80 V, V _{GS} = 10 V, I _D = 28 A
Gate to Source Charge	Q _{GS}		7		nC	
Gate to Drain Charge	Q _{GD}		13		nC	
Body Diode Forward Voltage *1	V _{F(S-D)}		1	1.5	V	I _F = 28 A, V _{GS} = 0 V
Reverse Recovery Time	t _{rr}		73		ns	I _F = 28 A, V _{GS} = 0 V, di/dt = 100 A/μs
Reverse Recovery Charge	Q _{rr}		175		nC	

Note: *1. Pulsed test

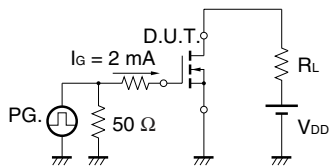
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME

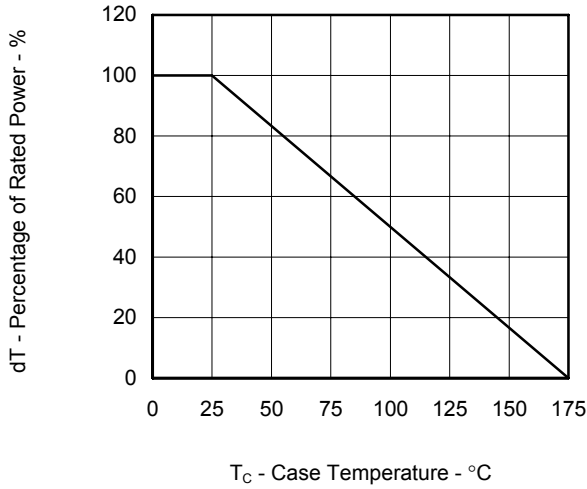


TEST CIRCUIT 3 GATE CHARGE

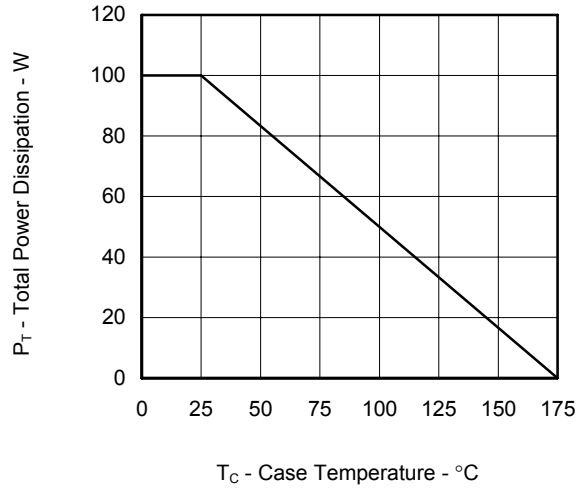


Typical Characteristics (T_A = 25°C)

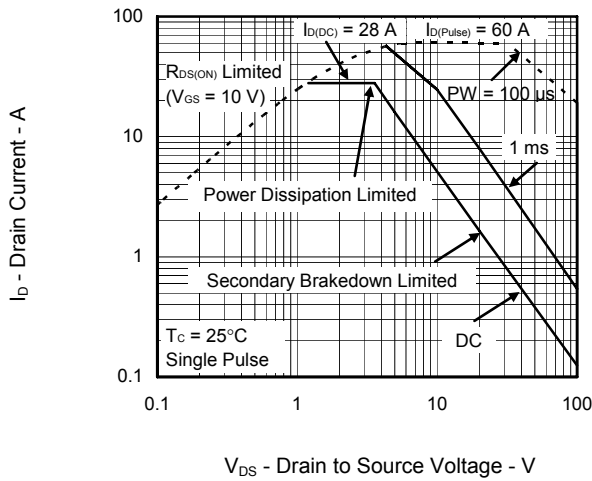
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



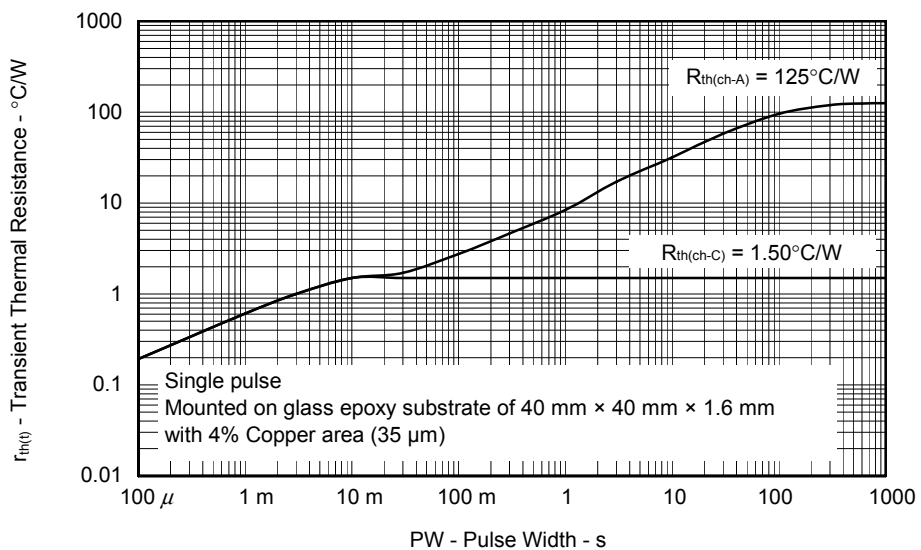
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



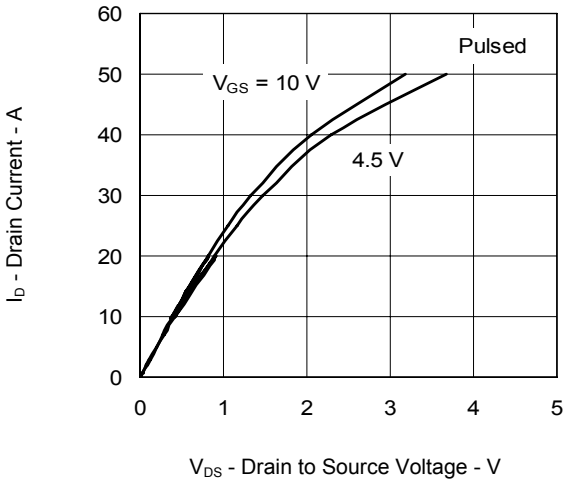
FORWARD BIAS SAFE OPERATING AREA



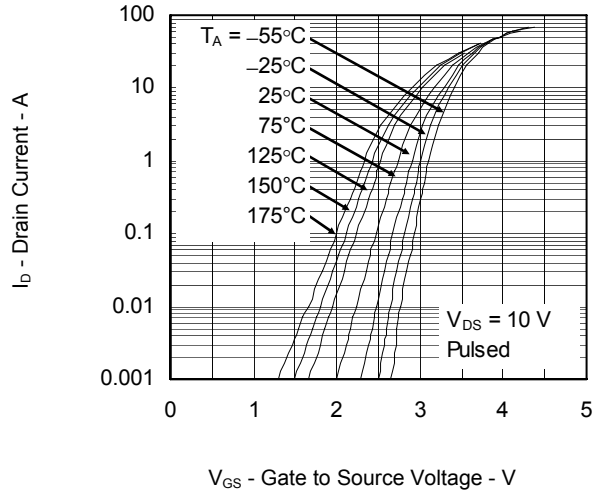
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



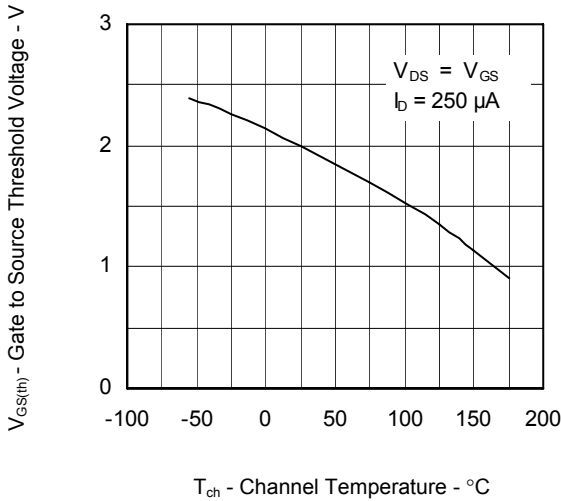
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



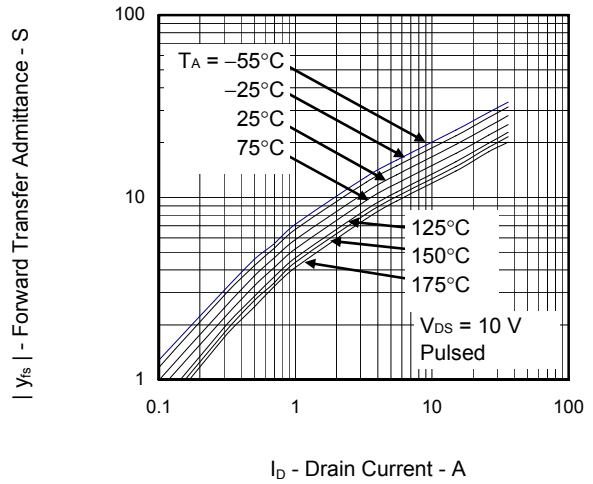
FORWARD TRANSFER CHARACTERISTICS



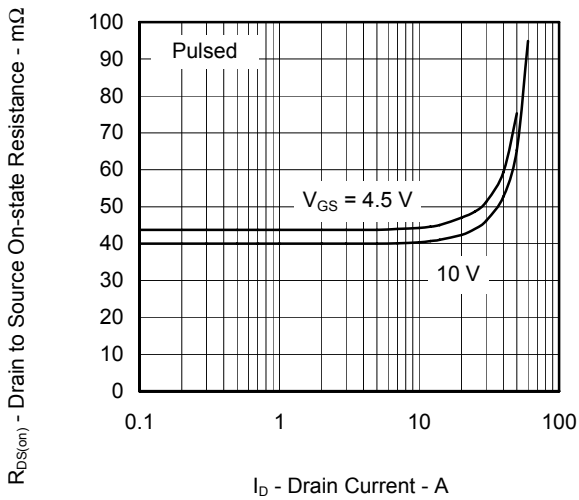
GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



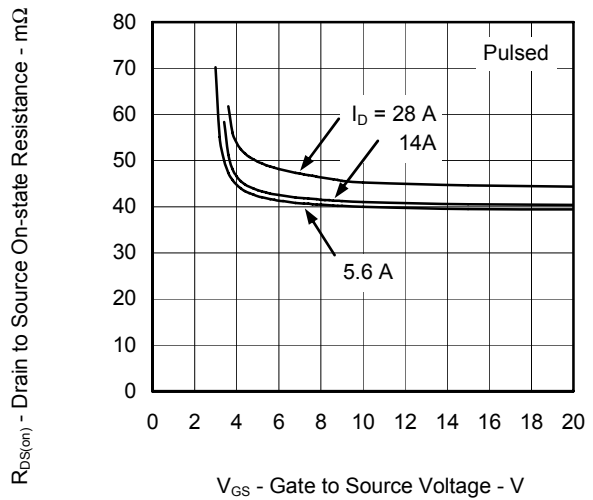
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



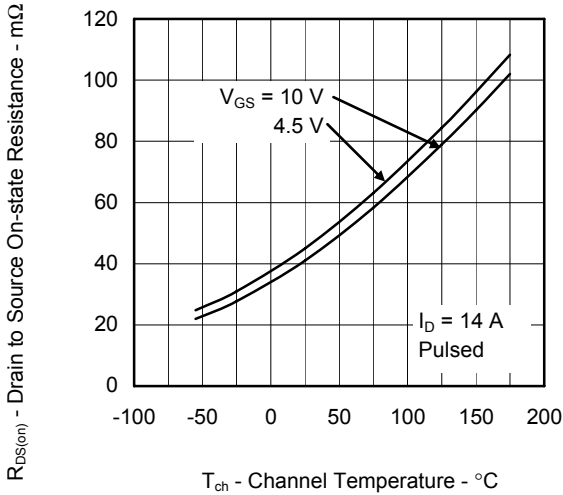
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



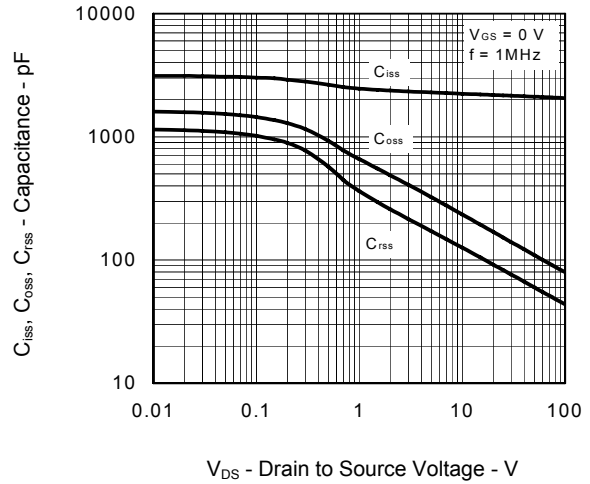
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



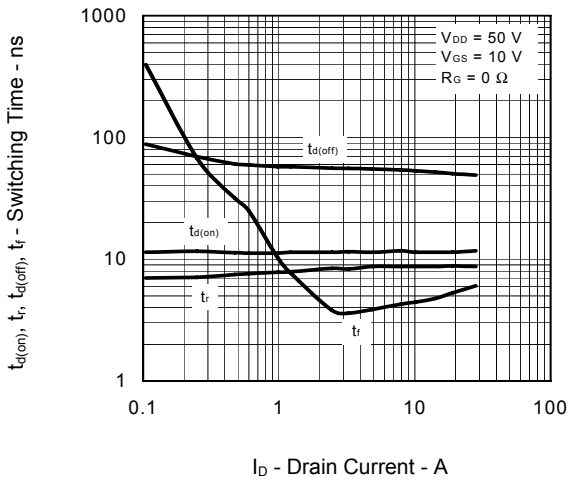
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



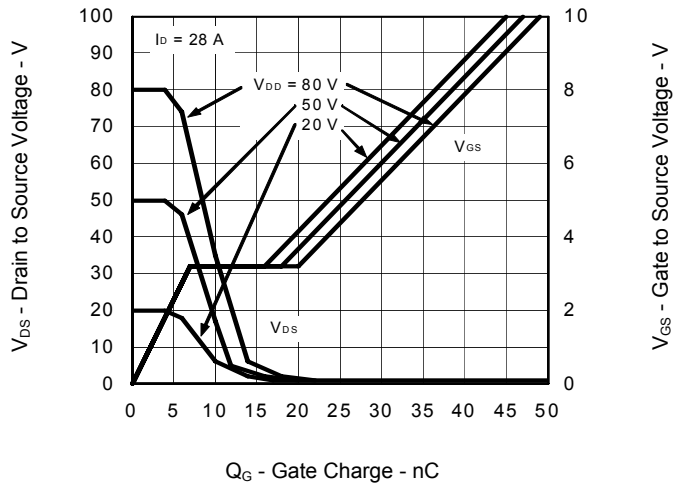
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



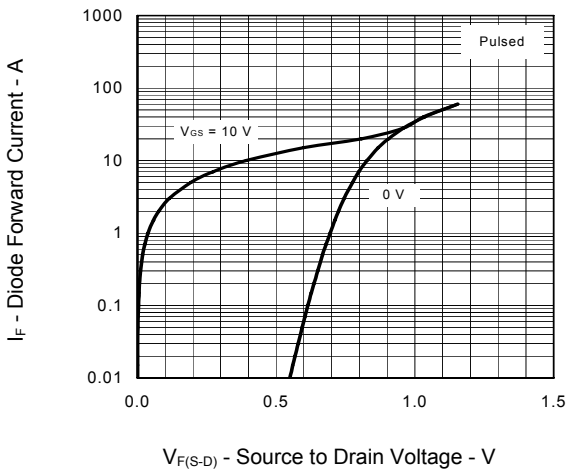
SWITCHING CHARACTERISTICS



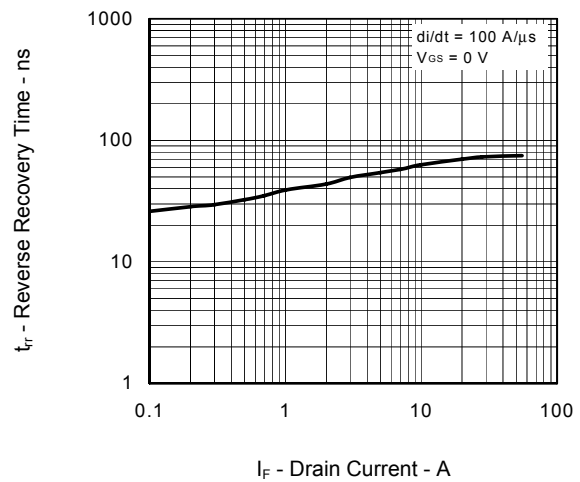
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

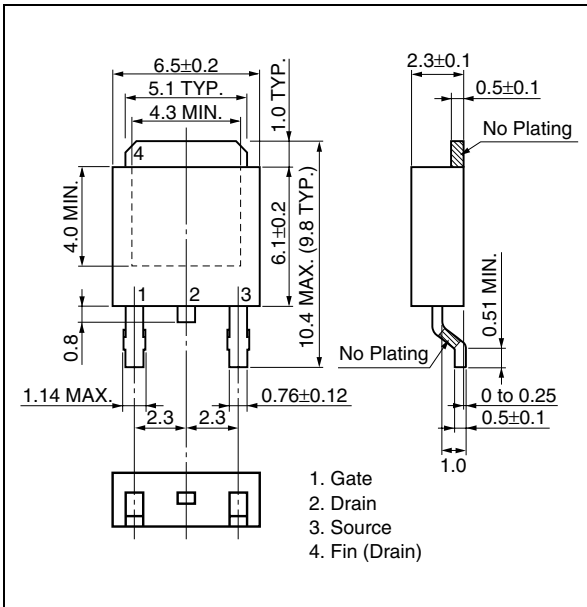


REVERSE RECOVERY TIME vs. DRAIN CURRENT

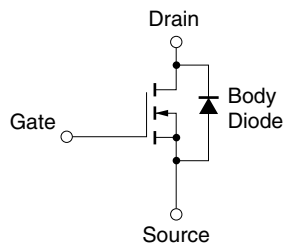


Package Drawing (Unit: mm)

TO-252 (MP-3ZK) (Mass: 0.27 g TYP.)



Equivalent Circuit



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

Revision History	NP28N10SDE Data Sheet
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Rev.	Date	Description	
		Page	Summary
1.00	Sep 16, 2011	-	First Edition Issued

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